

Notice of References Cited

Application/Control No.

10/676,271

Applicant(s)/Patent Under

Reexamination
JOHNSTON ET AL.

Examiner

Dimple N. Bodawala

Art Unit

1722

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2,974,361 A	03-1961	FERDINAND GERCKE; et. al.	425/229
*	B	US-3,557,407 A	01-1971	<i>Lemelson</i>	425/71
*	C	US-3,594,863 A	07-1971	Erb, George H.	425/505
*	D	US-3,659,989 A	05-1972	<i>Uraya et al</i>	425/131.5
*	E	US-3,782,875 A	01-1974	Olschewski, Paul	425/223
*	F	US-3,864,068 A	02-1975	Flakne, John R.	425/192R
*	G	US-4,437,827 A	03-1984	Moderlak et al.	425/378.2
*	H	US-5,149,481 A	09-1992	Gross et al.	264/210.2
*	I	US-5,268,132 A	12-1993	Keilert et al.	264/169
*	J	US-6,083,432 A	07-2000	Schafer, Klaus	264/39
*	K	US-6,306,327 B1	10-2001	Fujii et al.	264/210.2
*	L	US-6,409,491 B1	06-2002	Leffew et al.	425/67
*	M	US-6,495,214 B1	12-2002	Prix et al.	427/510

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

CA 4,17.07